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| <b>Search Notes</b><br> | <b>Application/Control No.</b><br>10626494 | <b>Applicant(s)/Patent Under Reexamination</b><br>DEVARAJAN ET AL. |
|  | <b>Examiner</b><br>Hajnik, Daniel F        | <b>Art Unit</b><br>2628  |

| SEARCHED |          |      |          |
|----------|----------|------|----------|
| Class    | Subclass | Date | Examiner |
|          |          |      |          |

| SEARCH NOTES  |         |          |
|---|---------|----------|
| Search Notes  | Date    | Examiner |
| Update search conducted in EAST   | 4/30/07 | DFH      |
| NPL Search conducted in ACM, IEEE, and Google, search terms include feature, loop, match, tree, and profile | 5/1/07  | DFH      |
| Presented claim 72 to QEM   | 5/3/07  | DFH      |
| EAST text search (US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB -- see search history printout)  | 5/3/07  | DFH      |

| INTERFERENCE SEARCH |          |      |          |
|---------------------|----------|------|----------|
| Class               | Subclass | Date | Examiner |
|                     |          |      |          |